











DRV8824-Q1

SLVSCH0-APRIL 2014

# DRV8824-Q1 Automotive Motor Controller IC

#### **Features**

- **Qualified for Automotive Applications**
- AEC-Q100 Qualified with the Following Results:
  - Device Temperature Grade 1: -40°C to +125°C
  - Device HBM ESD Classification Level H2
  - Device CDM ESD Classification Level C4B
- **PWM Microstepping Motor Driver** 
  - Built-In Microstepping Indexer
  - Five-Bit Winding Current Control Allows Up to 32 Current Levels
  - Low MOSFET On-Resistance
- 1.6-A Maximum Drive Current at 24 V, 25°C
- Built-In 3.3-V Reference Output
- 8.2-V to 45-V Operating Supply Voltage Range
- Thermally Enhanced HTSSOP Surface Mount Package

## **Applications**

- Automotive HVAC
- Automotive Valves
- Automotive Infotainment

## 3 Description

The DRV8824-Q1 provides an integrated motor driver solution for automotive applications. The device has two H-bridge drivers and a microstepping indexer, and is intended to drive a bipolar stepper motor. The output driver block for each consists of N-channel power MOSFET's configured as full H-bridges to drive the motor windings. The DRV8824-Q1 is capable of driving up to 1.6-A of output current (with proper heatsinking, at 24 V and 25°C).

simple step/direction interface allows interfacing to controller circuits. Terminals allow configuration of the motor in full-step up to 1/32-step modes. Decay mode is programmable.

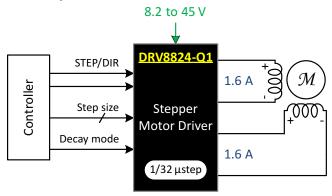
shutdown functions are provided for Internal overcurrent protection, short circuit protection, undervoltage lockout and overtemperature.

The DRV8824-Q1 is available in a 28-terminal HTSSOP package with PowerPAD™ (Eco-friendly: RoHS & no Sb/Br).

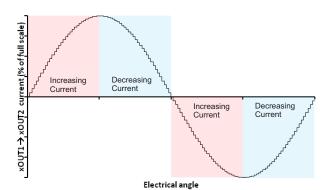
#### **Device Information**

ORDER NUMBER	PACKAGE	BODY SIZE
DRV8824QPWPRQ1	HTSSOP (28)	9.7 mm x 4.4 mm

# Simplified Schematic



## **Microstepping Current Waveform**







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# **5** Revision History

DATE	REVISION	NOTES
April 2014	*	Initial release.



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PWP Package

# 6 Terminal Configuration and Functions

BVREF 13

GND 14

#### (Top View) CP1 28 GND CP2 27 nHOME VCP 26 MODE2 VMA 4 25 MODE1 AOUT1 5 24 MODE0 ISENA 6 23 NC GND AOUT2 7 22 STEP (PPAD) BOUT2 8 21 nENBL ISENB 9 20 DIR BOUT1 10 19 DECAY VMB 11 18 nFAULT AVREF 12 17 nSLEEP

#### **Terminal Functions**

nRESET

15 V3P3OUT

NAME	TERMINAL	I/O	DESCRIPTION	EXTERNAL COMPONENTS OR CONNECTIONS
POWER AND GR	OUND			
GND	14, 28	-	Device ground	
VMA	4	-	Bridge A power supply	Connect to motor supply (8.2 V - 45 V). Both terminals
VMB	11	-	Bridge B power supply	must be connected to same supply.
V3P3OUT	15	0	3.3-V regulator output	Bypass to GND with a 0.47-µF 6.3-V ceramic capacitor. Can be used to supply VREF.
CP1	1	Ю	Charge pump flying capacitor	Connect a 0.01-µF 50-V capacitor between CP1 and
CP2	2	Ю	Charge pump flying capacitor	CP2.
VCP	3	Ю	High-side gate drive voltage	Connect a 0.1-µF 16-V ceramic capacitor and a 1-M $\!\Omega$ resistor to VM.
CONTROL				
nENBL	21	1	Enable input	Logic high to disable device outputs and indexer operation, logic low to enable. Internal pulldown.
nSLEEP	17	1	Sleep mode input	Logic high to enable device, logic low to enter low-power sleep mode. Internal pulldown.
STEP	22	I	Step input	Rising edge causes the indexer to move one step. Internal pulldown.
DIR	20	1	Direction input	Level sets the direction of stepping. Internal pulldown.
MODE0	24	I	Microstep mode 0	
MODE1	25	I	Microstep mode 1	MODE0 - MODE2 set the step mode - full, 1/2, 1/4, 1/8/ 1/16, or 1/32 step. Internal pulldown.
MODE2	26	I	Microstep mode 2	1707 1710, OF 1702 Stop. Internal pullation.
DECAY	19	1	Decay mode	Low = slow decay, open = mixed decay, high = fast decay. Internal pulldown and pullup.
nRESET	16	I	Reset input	Active-low reset input initializes the indexer logic and disables the H-bridge outputs. Internal pulldown.
AVREF	12	1	Bridge A current set reference input	Reference voltage for winding current set. Normally
BVREF	13	I	Bridge B current set reference input	AVREF and BVREF are connected to the same voltage. Can be connected to V3P3OUT. A 0.01-µF bypass capacitor to GND is recommended.
NC	23		No connect	Leave this terminal unconnected.
STATUS				
nHOME	27	OD	Home position	Logic low when at home state of step table
nFAULT	18	OD	Fault	Logic low when in fault condition (overtemp, overcurrent)





#### **Terminal Functions (continued)**

NAME	TERMINAL	1/0	DESCRIPTION	EXTERNAL COMPONENTS OR CONNECTIONS
OUTPUT	•			
ISENA	6	Ю	Bridge A ground / Isense	Connect to current sense resistor for bridge A.
ISENB	9	Ю	Bridge B ground / Isense	Connect to current sense resistor for bridge B.
AOUT1	5	0	Bridge A output 1	Connect to bipolar stepper motor winding A.
AOUT2	7	0	Bridge A output 2	Positive current is AOUT1 → AOUT2
BOUT1	10	0	Bridge B output 1	Connect to bipolar stepper motor winding B.
BOUT2	8	0	Bridge B output 2	Positive current is BOUT1 → BOUT2

# 7 Specifications

## 7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) (1)(2)

		VALUE	UNIT
VMx	Power supply voltage range	-0.3 to 47	V
	Digital terminal voltage range	–0.5 to 7	V
VREF	Input voltage	-0.3 to 4	V
	ISENSEx terminal voltage	-0.3 to 0.8	V
	Peak motor drive output current, t < 1 μS	Internally limited	Α
	Continuous motor drive output current <sup>(3)</sup>	1.6	Α
	Continuous total power dissipation	See Thermal Informat	ion table
TJ	Operating virtual junction temperature range	-40 to 150	°C

<sup>(1)</sup> Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute maximum rated conditions for extended periods may affect device reliability.

7.2 Handling Ratings

		MIN	MAX	UNIT
T <sub>stg</sub>	Storage temperature range	-60	150	°C
M	HBD (human body model), AEC-Q100 Classification H2		2000	V
V <sub>ESD</sub>	CDM (charged device model), AEC-Q100 Classification C4B		750	V

### 7.3 Recommended Operating Conditions

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		MIN	NOM MAX	UNIT
$V_{M}$	Motor power supply voltage <sup>(1)</sup>	8.2	45	V
$V_{REF}$	VREF input voltage <sup>(2)</sup>	1	3.5	V
I <sub>V3P3</sub>	V3P3OUT load current		1	mA

<sup>(1)</sup> All V<sub>M</sub> terminals must be connected to the same supply voltage.

<sup>(2)</sup> All voltage values are with respect to network ground terminal.

<sup>(3)</sup> Power dissipation and thermal limits must be observed.

<sup>(2)</sup> Operational at VREF between 0 V and 1 V, but accuracy is degraded.



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#### 7.4 Thermal Information

		DRV8824-Q1	
	THERMAL METRIC	PWP	UNIT
		28 TERMINAL	
$R_{\theta JA}$	Junction-to-ambient thermal resistance <sup>(1)</sup>	38.9	
R <sub>0</sub> JC(top)	Junction-to-case (top) thermal resistance (2)	23.3	
$R_{\theta JB}$	Junction-to-board thermal resistance (3)	21.2	°C/W
ΨЈТ	Junction-to-top characterization parameter (4)	0.8	-C/VV
ΨЈВ	Junction-to-board characterization parameter <sup>(5)</sup>	20.9	
R <sub>0JC(bot)</sub>	Junction-to-case (bottom) thermal resistance (6)	2.6	

- (1) The junction-to-ambient thermal resistance under natural convection is obtained in a simulation on a JEDEC-standard, high-K board, as specified in JESD51-7, in an environment described in JESD51-2a.
- The junction-to-case (top) thermal resistance is obtained by simulating a cold plate test on the package top. No specific JEDECstandard test exists, but a close description can be found in the ANSI SEMI standard G30-88.
- The junction-to-board thermal resistance is obtained by simulating in an environment with a ring cold plate fixture to control the PCB temperature, as described in JESD51-8.
- The junction-to-top characterization parameter,  $\psi_{JT}$ , estimates the junction temperature of a device in a real system and is extracted from the simulation data for obtaining  $\theta_{JA}$ , using a procedure described in JESD51-2a (sections 6 and 7).
- (5) The junction-to-board characterization parameter, ψ<sub>JB</sub>, estimates the junction temperature of a device in a real system and is extracted from the simulation data for obtaining  $\theta_{JA}$ , using a procedure described in JESD51-2a (sections 6 and 7).
- The junction-to-case (bottom) thermal resistance is obtained by simulating a cold plate test on the exposed (power) pad. No specific JEDEC standard test exists, but a close description can be found in the ANSI SEMI standard G30-88.

### 7.5 Electrical Characteristics

over operating free-air temperature range of -40°C to 125°C (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
POWER	SUPPLIES					
$I_{VM}$	VM operating supply current	V <sub>M</sub> = 24 V, f <sub>PWM</sub> < 50 kHz		5	8	mA
$I_{VMQ}$	VM sleep mode supply current	V <sub>M</sub> = 24 V		10	20	μΑ
$V_{\text{UVLO}}$	VM undervoltage lockout voltage	V <sub>M</sub> rising		7.8	8.2	V
V3P3OU	IT REGULATOR					
V	V2D2OLIT voltogo	IOUT = 0 to 1 mA, V <sub>M</sub> = 24 V, T <sub>J</sub> = 25°C	3.18	3.30	3.45	V
$V_{3P3}$	V3P3OUT voltage	IOUT = 0 to 1 mA	3.10	3.30	3.50	V
LOGIC-L	LEVEL INPUTS	·			·	
$V_{IL}$	Input low voltage			0.6	0.7	V
$V_{IH}$	Input high voltage		2		5.25	V
$V_{HYS}$	Input hysteresis			0.45		V
$I_{\rm IL}$	Input low current	VIN = 0	-20		20	μΑ
I <sub>IH</sub>	Input high current	VIN = 3.3 V			100	μΑ
2	Internal nulldayun registance	nENBL, nRESET, DIR, STEP, MODEx		100		kΩ
$R_{PD}$	Internal pulldown resistance	nSLEEP		1		ΜΩ
nHOME,	nFAULT OUTPUTS (OPEN-DRAIN C	OUTPUTS)				
$V_{OL}$	Output low voltage	I <sub>O</sub> = 5 mA			0.5	V
I <sub>OH</sub>	Output high leakage current	V <sub>O</sub> = 3.3 V			1	μΑ
DECAY	INPUT					
$V_{IL}$	Input low threshold voltage	For slow decay mode			0.8	V
V <sub>IH</sub>	Input high threshold voltage	For fast decay mode	2			V
I <sub>IN</sub>	Input current		-100		100	μΑ
R <sub>PU</sub>	Internal pullup resistance			130		kΩ
R <sub>PD</sub>	Internal pulldown resistance			80		kΩ

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# **Electrical Characteristics (continued)**

over operating free-air temperature range of -40°C to 125°C (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
H-BRIDG	E FETS		II.			
		V <sub>M</sub> = 24 V, I <sub>O</sub> = 1 A, T <sub>J</sub> = 25°C		0.63		
R <sub>DS(ON)</sub>	HS FET on resistance	V <sub>M</sub> = 24 V, I <sub>O</sub> = 1 A, T <sub>J</sub> = 85°C		0.76	0.90	Ω
	Note					
		V <sub>M</sub> = 24 V, I <sub>O</sub> = 1 A, T <sub>J</sub> = 25°C		0.65		
R <sub>DS(ON)</sub>	LS FET on resistance	V <sub>M</sub> = 24 V, I <sub>O</sub> = 1 A, T <sub>J</sub> = 85°C		0.78	0.90	Ω
		V <sub>M</sub> = 24 V, I <sub>O</sub> = 1 A, T <sub>J</sub> = 125°C		0.85	1	
I <sub>OFF</sub>	Off-state leakage current		-20		20	μΑ
MOTOR I	DRIVER					
f <sub>PWM</sub>	Internal PWM frequency			50		kHz
t <sub>BLANK</sub>	Current sense blanking time			3.75		μs
$t_R$	Rise time	V <sub>M</sub> = 24 V	100		360	ns
t <sub>F</sub>	Fall time	V <sub>M</sub> = 24 V	80		250	ns
t <sub>DEAD</sub>	Dead time			400		ns
PROTEC	TION CIRCUITS					
I <sub>OCP</sub>	Overcurrent protection trip level		1.8		5	Α
t <sub>TSD</sub>	Thermal shutdown temperature	Die temperature	150	160	180	°C
CURREN	T CONTROL					
I <sub>REF</sub>	xVREF input current	xVREF = 3.3 V	-3		3	μΑ
$V_{TRIP}$	xISENSE trip voltage	xVREF = 3.3 V, 100% current setting	635	660	685	mV
		xVREF = 3.3 V , 5% current setting	-25%		25%	
	Current trin conuracy	xVREF = 3.3 V, 10% - 34% current setting	-15%		15%	
$\Delta I_{TRIP}$	Current trip accuracy (relative to programmed value)	xVREF = 3.3 V, 38% - 67% current setting	-10%		10%	
		xVREF = 3.3 V, 71% - 100% current setting	-5%		5%	
A <sub>ISENSE</sub>	Current sense amplifier gain	Reference only		5		V/V

# 7.6 Timing Requirements

			MIN	MAX	UNIT
1	f <sub>STEP</sub>	Step frequency		250	kHz
2	t <sub>WH(STEP)</sub>	Pulse duration, STEP high	1.9		μs
3	t <sub>WL(STEP)</sub>	Pulse duration, STEP low	1.9		μs
4	t <sub>SU(STEP)</sub>	Setup time, command to STEP rising	200		ns
5	t <sub>H(STEP)</sub>	Hold time, command to STEP rising	200		ns
6	t <sub>ENBL</sub>	Enable time, nENBL active to STEP	200		ns
7	t <sub>WAKE</sub>	Wakeup time, nSLEEP inactive to STEP	1		ms



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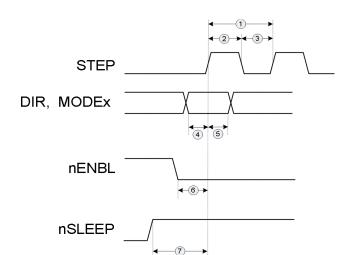
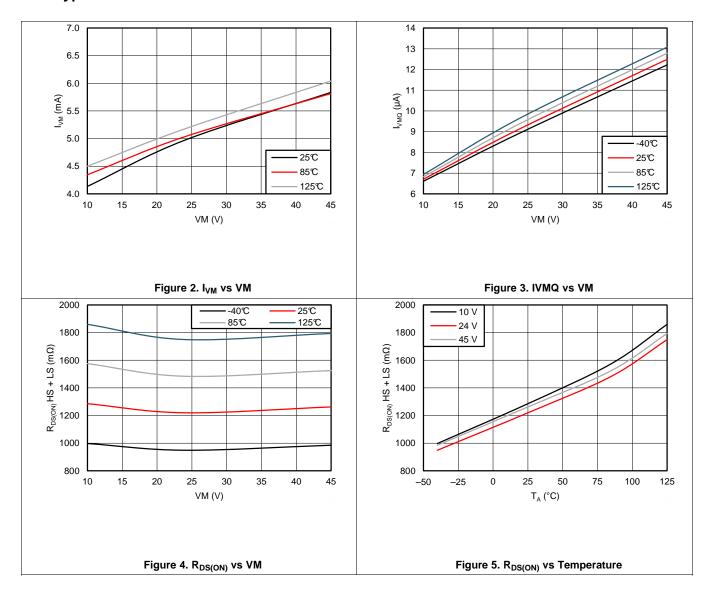


Figure 1. Timing Diagram

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# 7.7 Typical Characteristics





# 8 Detailed Description

#### 8.1 Overview

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The DRV8824-Q1 is an integrated motor driver solution for bipolar stepper motors. The device integrates two NMOS H-bridges, current sense and regulation circuitry, and a microstepping indexer. The DRV8824-Q1 can be powered with a supply voltage between 8.2 V and 45 V, and is capable of providing an output current up to 1.6 A full-scale or 1.1 A rms.

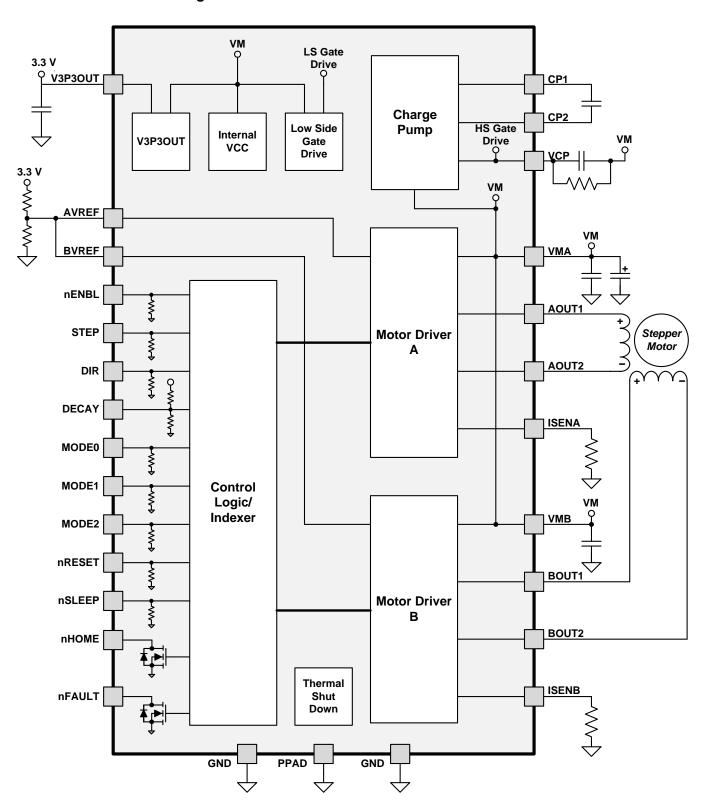
A simple STEP/DIR interface allows easy interfacing to the controller circuit. The internal indexer is able to execute high-accuracy microstepping without requiring the processor to control the current level.

The current regulation is highly configurable, with three decay modes of operation. Fast, slow, and mixed decay can be used.

A low-power sleep mode is included which allows the system to save power when not driving the motor.

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# 8.2 Functional Block Diagram





## 8.3 Feature Description

#### 8.3.1 PWM Motor Drivers

The DRV8824-Q1 contains two H-bridge motor drivers with current-control PWM circuitry. A block diagram of the motor control circuitry is shown in Figure 6.

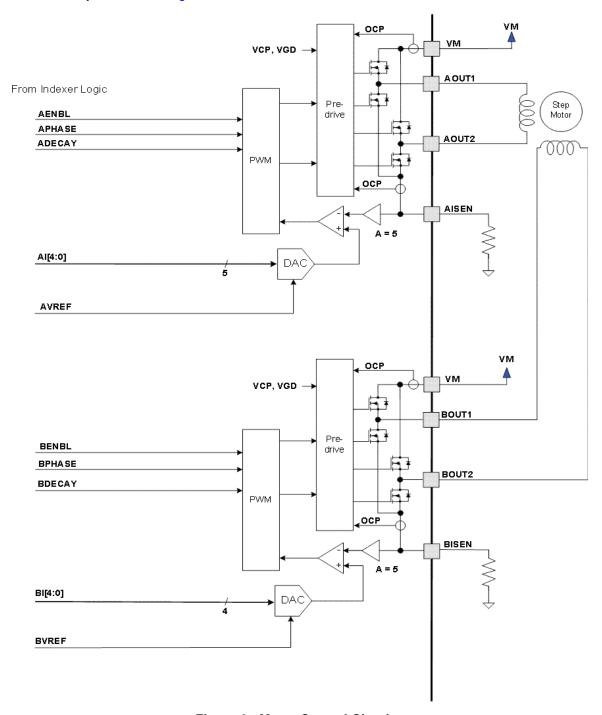


Figure 6. Motor Control Circuitry

Note that there are multiple VM motor power supply terminals. All VM terminals must be connected together to the motor supply voltage.

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### **Feature Description (continued)**

### 8.3.2 Current Regulation

The current through the motor windings is regulated by a fixed-frequency PWM current regulation, or current chopping. When an H-bridge is enabled, current rises through the winding at a rate dependent on the DC voltage and inductance of the winding. Once the current hits the current chopping threshold, the bridge disables the current until the beginning of the next PWM cycle.

In stepping motors, current regulation is used to vary the current in the two windings in a semi-sinusoidal fashion to provide smooth motion.

The PWM chopping current is set by a comparator which compares the voltage across a current sense resistor connected to the xISEN terminals, multiplied by a factor of 5, with a reference voltage. The reference voltage is input from the xVREF terminals.

The full-scale (100%) chopping current is calculated in Equation 1.

$$I_{CHOP} = \frac{V_{REFX}}{5 \cdot R_{ISENSE}} \tag{1}$$

#### Example:

If a  $0.5-\Omega$  sense resistor is used and the VREFx terminal is 3.3 V, the full-scale (100%) chopping current will be 3.3 V / (5 x 0.5  $\Omega$ ) = 1.32 A.

The reference voltage is scaled by an internal DAC that allows fractional stepping of a bipolar stepper motor, as described in the microstepping indexer section below.

#### 8.3.3 Blanking Time

After the current is enabled in an H-bridge, the voltage on the xISEN terminal is ignored for a fixed period of time before enabling the current sense circuitry. This blanking time is fixed at 3.75 µs. Note that the blanking time also sets the minimum on time of the PWM.

#### 8.3.4 Microstepping Indexer

Built-in indexer logic in the DRV8824-Q1 allows a number of different stepping configurations. The MODE0 - MODE2 terminals are used to configure the stepping format as shown in .

MODE0 MODE2 MODE1 STEP MODE 0 0 0 Full step (2-phase excitation) with 71% current 0 0 1 1/2 step (1-2 phase excitation) 0 1 0 1/4 step (W1-2 phase excitation) 0 1 1 8 microsteps / step 1 0 0 16 microsteps / step 1 0 1 32 microsteps / step 1 1 0 32 microsteps / step 1 32 microsteps / step

**Table 1. Stepping Format** 

Table 2 shows the relative current and step directions for different settings of MODEx. At each rising edge of the STEP input, the indexer travels to the next state in the table. The direction is shown with the DIR terminal high; if the DIR terminal is low the sequence is reversed. Positive current is defined as xOUT1 = positive with respect to xOUT2.

Note that if the step mode is changed while stepping, the indexer will advance to the next valid state for the new MODEx setting at the rising edge of STEP.

The home state is 45°. This state is entered at power-up or application of nRESET. This is shown in Table 2 by the shaded cells. The logic inputs DIR, STEP, nRESET and MODEx have an internal pulldown resistors of 100  $k\Omega$ 



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# Table 2. Relative Current and Step Directions

Table 2. Relative Current and Step Directions											
1/32 STEP	1/16 STEP	1/8 STEP	1/4 STEP	1/2 STEP	FULL STEP 70%	WINDING CURRENT A	WINDING CURRENT B	ELECTRICAL ANGLE			
1	1	1	1	1		100%	0%	0			
2						100%	5%	3			
3	2					100%	10%	6			
4						99%	15%	8			
5	3	2				98%	20%	11			
6						97%	24%	14			
7	4					96%	29%	17			
8						94%	34%	20			
9	5	3	2			92%	38%	23			
10						90%	43%	25			
11	6					88%	47%	28			
12						86%	51%	31			
13	7	4				83%	56%	34			
14						80%	60%	37			
15	8					77%	63%	39			
16						74%	67%	42			
17	9	5	3	2	1	71%	71%	45			
18						67%	74%	48			
19	10					63%	77%	51			
20						60%	80%	53			
21	11	6				56%	83%	56			
22						51%	86%	59			
23	12					47%	88%	62			
24						43%	90%	65			
25	13	7	4			38%	92%	68			
26						34%	94%	70			
27	14					29%	96%	73			
28						24%	97%	76			
29	15	8				20%	98%	79			
30						15%	99%	82			
31	16					10%	100%	84			
32						5%	100%	87			
33	17	9	5	3		0%	100%	90			
34						-5%	100%	93			
35	18					-10%	100%	96			
36						-15%	99%	98			
37	19	10				-20%	98%	101			
38						-24%	97%	104			
39	20					-29%	96%	107			
40						-34%	94%	110			
41	21	11	6			-38%	92%	113			
42						-43%	90%	115			
43	22					-47%	88%	118			
44						-51%	86%	121			
45	23	12				-56%	83%	124			
46						-60%	80%	127			

# **Table 2. Relative Current and Step Directions (continued)**

Table 2. Nelative our ent and Step Directions (continued)										
1/32 STEP	1/16 STEP	1/8 STEP	1/4 STEP	1/2 STEP	FULL STEP 70%	WINDING CURRENT A	WINDING CURRENT B	ELECTRICAL ANGLE		
47	24					-63%	77%	129		
48					-67% 74%		132			
49	25	13	7	4 2 -71% 71%		135				
50				<b>–74</b> % 67%		138				
51	26				-77% 63%		141			
52						-80%	60%	143		
53	27	14				-83%	56%	146		
54						-86%	51%	149		
55	28					-88%	47%	152		
56						-90%	43%	155		
57	29	15	8			-92%	38%	158		
58						-94%	34%	160		
59	30					-96%	29%	163		
60						-97%	24%	166		
61	31	16				-98%	20%	169		
62						-99%	15%	172		
63	32					-100%	10%	174		
64						-100%	5%	177		
65	33	17	9	5		-100%	0%	180		
66						-100%	-5%	183		
67	34					-100%	-10%	186		
68						-99%	-15%	188		
69	35	18				-98%	-20%	191		
70						-97%	-24%	194		
71	36					-96%	-29%	197		
72						-94%	-34%	200		
73	37	19	10			-92%	-38%	203		
74						-90%	-43%	205		
75	38					-88%	-47%	208		
76						-86%	-51%	211		
77	39	20				-83%	-56%	214		
78						-80%	-60%	217		
79	40					-77%	-63%	219		
80						-74%	-67%	222		
81	41	21	11	6	3	-71%	-71%	225		
82						-67%	-74%	228		
83	42					-63%	-77%	231		
84						-60%	-80%	233		
85	43	22				-56%	-83%	236		
86						-51%	-86%	239		
87	44					-47%	-88%	242		
88						-43%	-90%	245		
89	45	23	12			-38%	-92%	248		
90						-34%	-94%	250		
91	46					-29%	-96%	253		
92						-24%	-97%	256		



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Table 2. Relative Current and Step Directions (continued)

1/32 STEP	1/16 STEP	1/8 STEP	1/4 STEP	1/2 STEP	FULL STEP 70%	WINDING CURRENT A	WINDING CURRENT B	ELECTRICAL ANGLE
93	47	24				-20% -98%		259
94					-15% -10%		-99%	262
95	48						-100%	264
96						-5%	-100%	267
97	49	25	13	7		0%	-100%	270
98						5%	-100%	273
99	50					10%	-100%	276
100						15%	-99%	278
101	51	26				20%	-98%	281
102						24%	-97%	284
103	52					29%	-96%	287
104						34%	-94%	290
105	53	27	14			38%	-92%	293
106						43%	-90%	295
107	54					47%	-88%	298
108						51%	-86%	301
109	55	28				56%	-83%	304
110						60%	-80%	307
111	56					63%	-77%	309
112						67%	-74%	312
113	57	29	15	8	4	71%	-71%	315
114						74%	-67%	318
115	58					77%	-63%	321
116						80%	-60%	323
117	59	30				83%	-56%	326
118						86%	-51%	329
119	60					88%	-47%	332
120						90%	-43%	335
121	61	31	16			92%	-38%	338
122						94%	-34%	340
123	62					96%	-29%	343
124						97%	-24%	346
125	63	32				98%	-20%	349
126						99%	-15%	352
127	64					100%	-10%	354
128						100%	-5%	357

## 8.3.5 nRESET, nENBLE and nSLEEP Operation

The nRESET terminal, when driven active low, resets internal logic, and resets the step table to the home position. It also disables the H-bridge drivers. The STEP input is ignored while nRESET is active.

The nENBL terminal is used to control the output drivers and enable/disable operation of the indexer. When nENBL is low, the output H-bridges are enabled, and rising edges on the STEP terminal are recognized. When nENBL is high, the H-bridges are disabled, the outputs are in a high-impedance state, and the STEP input is ignored.

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Driving nSLEEP low will put the device into a low power sleep state. In this state, the H-bridges are disabled, the gate drive charge pump is stopped, the V3P3OUT regulator is disabled, and all internal clocks are stopped. In this state all inputs are ignored until nSLEEP returns inactive high. When returning from sleep mode, some time (approximately 1 ms) needs to pass before applying a STEP input, to allow the internal circuitry to stabilize.

The nRESET and nENABLE terminals have internal pulldown resistors of 100 k $\Omega$ . The nSLEEP terminal has an internal pulldown resistor of 1 M $\Omega$ .

#### 8.3.6 Protection Circuits

The DRV8824-Q1 is fully protected against undervoltage, overcurrent and overtemperature events.

#### 8.3.6.1 Overcurrent Protection (OCP)

An analog current limit circuit on each FET limits the current through the FET by removing the gate drive. If this analog current limit persists for longer than the OCP time, all FETs in the H-bridge will be disabled and the nFAULT terminal will be driven low. The device will remain disabled until either nRESET terminal is applied, or VM is removed and re-applied.

Overcurrent conditions on both high and low side devices; i.e., a short to ground, supply, or across the motor winding will all result in an overcurrent shutdown. Note that overcurrent protection does not use the current sense circuitry used for PWM current control, and is independent of the I<sub>SENSE</sub> resistor value or VREF voltage.

#### 8.3.6.2 Thermal Shutdown (TSD)

If the die temperature exceeds safe limits, all FETs in the H-bridge will be disabled and the nFAULT terminal will be driven low. Once the die temperature has fallen to a safe level operation will automatically resume.

#### 8.3.6.3 Undervoltage Lockout (UVLO)

If at any time the voltage on the VM terminals falls below the undervoltage lockout threshold voltage, all circuitry in the device will be disabled and internal logic will be reset. Operation will resume when  $V_M$  rises above the UVLO threshold.

#### 8.3.7 Thermal Information

#### 8.3.7.1 Thermal Protection

The DRV8824-Q1 has thermal shutdown (TSD) as described above. If the die temperature exceeds approximately 150°C, the device will be disabled until the temperature drops to a safe level.

Any tendency of the device to enter TSD is an indication of either excessive power dissipation, insufficient heatsinking, or too high an ambient temperature.

### 8.3.7.2 Power Dissipation

Power dissipation in the DRV8824-Q1 is dominated by the power dissipated in the output FET resistance, or  $R_{DS(ON)}$ . Average power dissipation when running a stepper motor can be roughly estimated by Equation 2.

$$P_{TOT} = 4 \cdot R_{DS(ON)} \cdot (I_{OUT(RMS)})^2$$
 (2)

where  $P_{TOT}$  is the total power dissipation,  $R_{DS(ON)}$  is the resistance of each FET, and  $I_{OUT(RMS)}$  is the RMS output current being applied to each winding.  $I_{OUT(RMS)}$  is equal to the approximately 0.7x the full-scale output current setting. The factor of 4 comes from the fact that there are two motor windings, and at any instant two FETs are conducting winding current for each winding (one high-side and one low-side).

The maximum amount of power that can be dissipated in the device is dependent on ambient temperature and heatsinking.

Note that  $R_{DS(ON)}$  increases with temperature, so as the device heats, the power dissipation increases. This must be taken into consideration when sizing the heatsink.

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#### 8.3.7.3 Heatsinking

The PowerPAD™ package uses an exposed pad to remove heat from the device. For proper operation, this pad must be thermally connected to copper on the PCB to dissipate heat. On a multi-layer PCB with a ground plane, this can be accomplished by adding a number of vias to connect the thermal pad to the ground plane. On PCBs without internal planes, copper area can be added on either side of the PCB to dissipate heat. If the copper area is on the opposite side of the PCB from the device, thermal vias are used to transfer the heat between top and bottom lavers.

For details about how to design the PCB, refer to TI application report SLMA002, "PowerPAD™ Thermally Enhanced Package" and TI application brief SLMA004, "PowerPAD™ Made Easy", available at www.ti.com.

In general, the more copper area that can be provided, the more power can be dissipated. It can be seen that the heatsink effectiveness increases rapidly to about 20 cm<sup>2</sup>, then levels off somewhat for larger areas.

#### 8.4 Device Functional Modes

#### 8.4.1 Decay Mode

During PWM current chopping, the H-bridge is enabled to drive current through the motor winding until the PWM current chopping threshold is reached. This is shown in Figure 7 as case 1. The current flow direction shown indicates positive current flow.

Once the chopping current threshold is reached, the H-bridge can operate in two different states, fast decay or slow decay.

In fast decay mode, once the PWM chopping current level has been reached, the H-bridge reverses state to allow winding current to flow in a reverse direction. As the winding current approaches zero, the bridge is disabled to prevent any reverse current flow. Fast decay mode is shown in Figure 7 as case 2.

In slow decay mode, winding current is re-circulated by enabling both of the low-side FETs in the bridge. This is shown in Figure 7 as case 3.

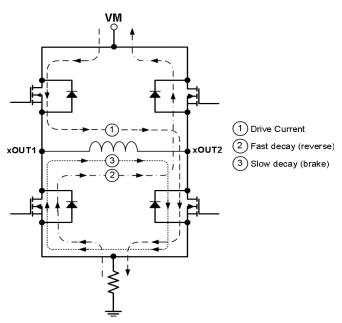


Figure 7. Decay Mode

The DRV8824-Q1 supports fast decay, slow decay and a mixed decay mode. Slow, fast, or mixed decay mode is selected by the state of the DECAY terminal - logic low selects slow decay, open selects mixed decay operation. and logic high sets fast decay mode. The DECAY terminal has both an internal pullup resistor of approximately 130 k $\Omega$  and an internal pulldown resistor of approximately 80 k $\Omega$ . This sets the mixed decay mode if the terminal is left open or undriven.

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#### **Device Functional Modes (continued)**

Mixed decay mode begins as fast decay, but at a fixed period of time (75% of the PWM cycle) switches to slow decay mode for the remainder of the fixed PWM period. This occurs only if the current through the winding is decreasing (per the indexer step table); if the current is increasing, then slow decay is used.

## 9 Application and Implementation

#### 9.1 Application Information

The DRV8824-Q1 is used in bipolar stepper control. The following design procedure can be used to configure the DRV8824-Q1.

## 9.2 Typical Application

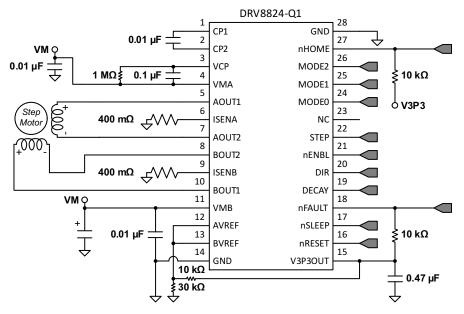


Figure 8. Typical Application Schematic

#### 9.2.1 Design Requirements

Table 3 gives design input parameters for system design.

**Table 3. Design Parameters** 

DESIGN PARAMETER	REFERENCE	EXAMPLE VALUE
Supply voltage	VM	24 V
Motor winding resistance	$R_{L}$	1.0 Ω/phase
Motor winding inductance	LL	3.5 mH/phase
Motor full step angle	$ heta_{ ext{step}}$	1.8°/step
Target microstepping level	n <sub>m</sub>	8 microsteps per step
Target motor speed	v	120 rpm
Target full-scale current	I <sub>FS</sub>	1.25 A

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## 9.2.2 Detailed Design Procedure

#### 9.2.2.1 Stepper Motor Speed

The first step in configuring the DRV8824-Q1 requires the desired motor speed and microstepping level. If the target application requires a constant speed, then a square wave with frequency fstep must be applied to the STEP pin.

If the target motor speed is too high, the motor will not spin. Make sure that the motor can support the target speed.

For a desired motor speed (v), microstepping level ( $n_m$ ), and motor full step angle ( $\theta_{step}$ ),

$$f_{step}(step/sec) = \frac{v(rpm) \cdot n_m(steps) \cdot 6}{\theta_{step}(^{\circ}/step)}$$
(3)

 $\theta_{\text{step}}$  can be found in the stepper motor datasheet or written on the motor itself.

For the DRV8824-Q1, the microstepping level is set by the USM pins and can be any of the settings in . Higher microstepping will mean a smother motor motion and less audible noise, but will increase switching losses and require a higher f<sub>step</sub> to achieve the same motor speed.

#### 9.2.2.2 Current Regulation

In a stepper motor, the full-scale current (I<sub>FS</sub>) is the maximum current driven through either winding. This quantity will depend on the VREF analog voltage and the sense resistor value (R<sub>SENSE</sub>). During stepping, I<sub>FS</sub> defines the current chopping threshold  $(I_{TRIP})$  for the maximum current step.

$$I_{FS}(A) = \frac{VREF(V)}{A_v \cdot R_{SENSE}(\Omega)} = \frac{VREF(V)}{5 \cdot R_{SENSE}(\Omega)}$$
(4)

 $I_{\text{FS}}$  is set by a comparator which compares the voltage across  $R_{\text{SENSE}}$  to a reference voltage. There is a current sense amplifier built in with programmable gain through ISGAIN. Note that I<sub>FS</sub> must also follow the equation below in order to avoid saturating the motor. VM is the motor supply voltage and R<sub>L</sub> is the motor winding

$$I_{FS}(A) < \frac{VM(V)}{R_L(\Omega) + 2 \cdot R_{DS(ON)}(\Omega) + RSENSE(\Omega)}$$
(5)

#### 9.2.2.3 Decay Modes

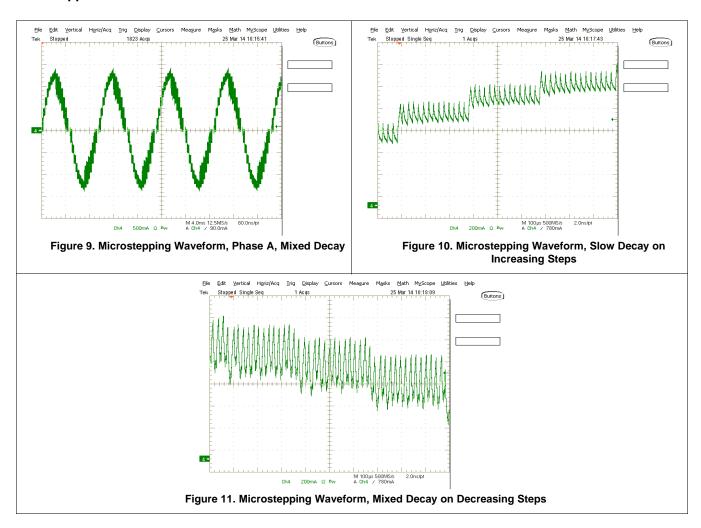
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The DRV8824-Q1 supports three different decay modes: slow decay, fast decay, and mixed decay. The current through the motor windings is regulated using a fixed-frequency PWM scheme. This means that after any drive phase, when a motor winding current has hit the current chopping threshold (I<sub>TRIP</sub>), the DRV8824-Q1 will place the winding in one of the three decay modes until the PWM cycle has expired. Afterwards, a new drive phase starts.

The blanking time t<sub>BLANK</sub> defines the minimum drive time for the current chopping. I<sub>TRIP</sub> is ignored during t<sub>BLANK</sub>, so the winding current may overshoot the trip level.

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#### 9.2.3 Application Curves



## 10 Power Supply Recommendations

The DRV8824-Q1 is designed to operate from an input voltage supply (VM) range between 8.2 V and 45 V. Two 0.01-µF ceramic capacitorS rated for VMA and VMB must be placed as close to the DRV8824-Q1 as possible. In addition, a bulk capacitor must be included. If VMA and VMB are connected to the same board net, a single bulk capacitor is sufficient.



### 11 Layout

## 11.1 Layout Guidelines

The VMA and VMB terminals should be bypassed to GND using low-ESR ceramic bypass capacitors with a recommended value of  $0.01~\mu F$  rated for VM. This capacitor should be placed as close to the VMA and VMB pins as possible with a thick trace or ground plane connection to the device GND pin.

The VMA and VMB pins must be bypassed to ground using a bulk capacitor. This component may be an electrolytic. If VMA and VMB are connected to the same board net, a single bulk capacitor is sufficient.

A low-ESR ceramic capacitor must be placed in between the CPL and CPH pins. A value of 0.01  $\mu$ F rated for VMA and VMB is recommended. Place this component as close to the pins as possible.

A low-ESR ceramic capacitor must be placed in between the VMA and VCP pins. A value of 0.1  $\mu$ F rated for 16 V is recommended. Place this component as close to the pins as possible. In addition place a 1-M $\Omega$  resistor between VCP and VMA.

Bypass V3P3 to ground with a ceramic capacitor rated 6.3 V. Place this bypassing capacitor as close to the pin as possible.

### 11.2 Layout Example

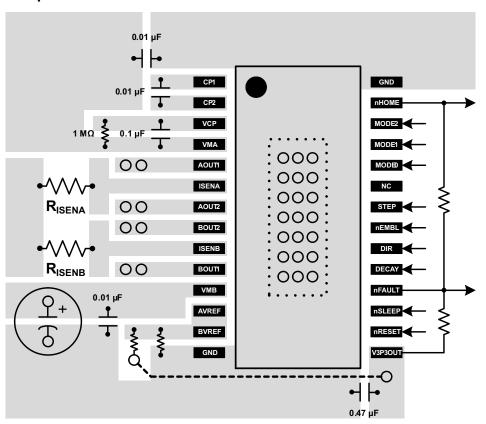


Figure 12. DRV8824-Q1 Board Layout

# TEXAS INSTRUMENTS

# 12 Device and Documentation Support

#### 12.1 Trademarks

PowerPAD is a trademark of Texas Instruments. All other trademarks are the property of their respective owners.

## 12.2 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

## 12.3 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms and definitions.

# 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



## PACKAGE OPTION ADDENDUM

6-Feb-2020

#### PACKAGING INFORMATION

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Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
DRV8824QPWPRQ1	ACTIVE	HTSSOP	PWP	28	2000	Green (RoHS & no Sb/Br)	NIPDAU	Level-3-260C-168 HR	-40 to 125	DRV8824Q1	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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#### OTHER QUALIFIED VERSIONS OF DRV8824-Q1:



# **PACKAGE OPTION ADDENDUM**

6-Feb-2020

• Catalog: DRV8824

NOTE: Qualified Version Definitions:

• Catalog - TI's standard catalog product

**PACKAGE MATERIALS INFORMATION** 

www.ti.com 26-Feb-2019

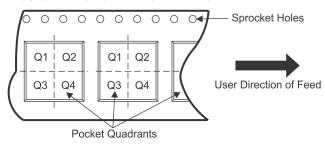
## TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

## QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
DRV8824QPWPRQ1	HTSSOP	PWP	28	2000	330.0	16.4	6.9	10.2	1.8	12.0	16.0	Q1

www.ti.com 26-Feb-2019

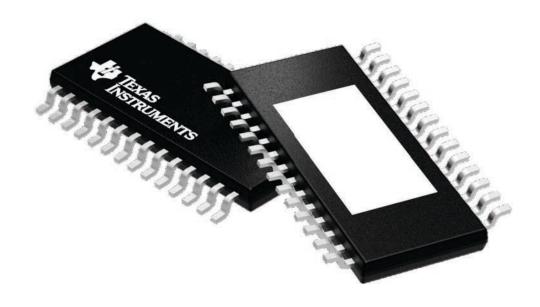


#### \*All dimensions are nominal

Device	Device Package Type		Pins SPQ		Length (mm)	Width (mm)	Height (mm)	
DRV8824QPWPRQ1	HTSSOP	PWP	28	2000	350.0	350.0	43.0	

4.4 x 9.7, 0.65 mm pitch

SMALL OUTLINE PACKAGE



Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.

4224765/A



PWP (R-PDSO-G28)

# PowerPAD™ PLASTIC SMALL OUTLINE



NOTES:

- All linear dimensions are in millimeters.
- This drawing is subject to change without notice.
- Body dimensions do not include mold flash or protrusions. Mold flash and protrusion shall not exceed 0.15 per side.
- This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPad Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 for information regarding recommended board layout. This document is available at www.ti.com <a href="http://www.ti.com">www.ti.com</a>.

  E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
- E. Falls within JEDEC MO-153

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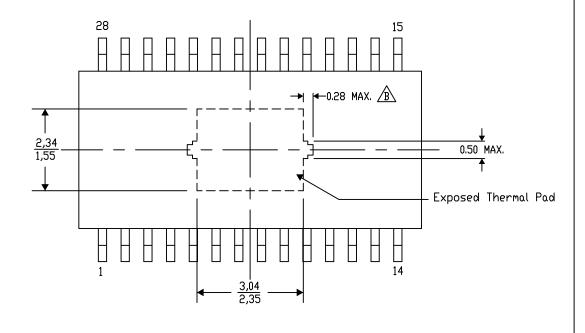
# PWP (R-PDSO-G28) PowerPAD™ SMALL PLASTIC OUTLINE

#### THERMAL INFORMATION

This PowerPAD<sup>TM</sup> package incorporates an exposed thermal pad that is designed to be attached to a printed circuit board (PCB). The thermal pad must be soldered directly to the PCB. After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For additional information on the PowerPAD package and how to take advantage of its heat dissipating abilities, refer to Technical Brief, PowerPAD Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 and Application Brief, PowerPAD Made Easy, Texas Instruments Literature No. SLMA004. Both documents are available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



Top View

Exposed Thermal Pad Dimensions

4206332-39/AO 01/16

NOTE: A. All linear dimensions are in millimeters

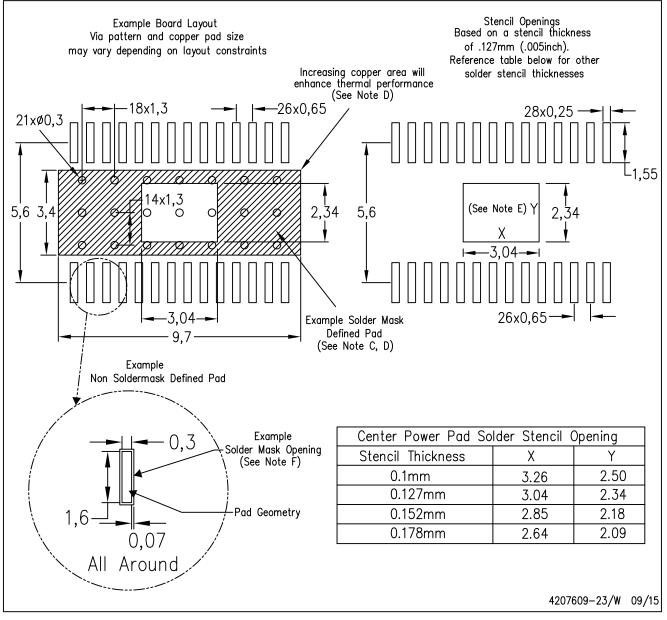
Exposed tie strap features may not be present.

PowerPAD is a trademark of Texas Instruments



# PWP (R-PDSO-G28)

# PowerPAD™ PLASTIC SMALL OUTLINE



#### NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPad Thermally Enhanced Package, Texas Instruments Literature No. SLMA002, SLMA004, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <a href="http://www.ti.com">http://www.ti.com</a>. Publication IPC-7351 is recommended for alternate designs.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.
- F. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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